

Enhancement Mode N-Channel Power MOSFET

 $TO-252/NMOS/40V/\pm20V/1.9V/130A/3.2m\Omega$

Rev_{0.6}





40V, 3.2mΩ, 130A, Single N-Channel

1.Features

- ◆ 40V MOSFET technology
- ◆ Low on-state resistance
- Fast switching
- ♦ Vgs±20V

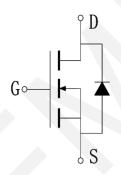
2.A	pp	lica	tio	ns
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- ♦ Power Switching Application
- Load Switching



Pin Description

V _{DS}	R _{DS(on)} Typ.	I _D Max.
40V	3.2mΩ @ 10V	1201
	4.3mΩ @ 4.5V	130A



Schematic Diagram

3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WP40H30K	WP40H30K	TO-252	2,500	25,000

4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units			
Drain to Source Voltage	V _{DSS}	40	V			
Gate to Source Voltage	V _{GSS}	±20	V			
Drain Current (DC)	ID	130	Α			
Drain Current (Pulse), PW≤300μs	I _{DP}	390	Α			
Total Dissipation	P _D	6.2	W			
Avalanche Energy, Single Pulsed	Eas	272	mJ			
Junction Temperature	Tj	150	°C			
Storage Temperature	T _{stg}	-55 to +150	°C			

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



5. Thermal Resistance Ratings

Parameter	Symbol	Value	Unit
Junction to case	Rejc	1.14	°C/W

Note 2: When mounted on 1 inch square copper board $t \le 10$ sec The value in any given application depends on the user's specific board design.

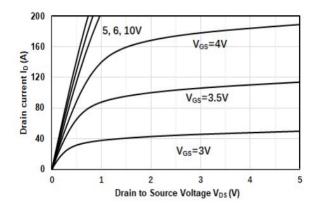
6.Electrical Characteristics at Ta=25°C (Note 3)

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V _{(BR)DSS}	$I_D = 250 \mu A$, $V_{GS} = 0 V$	40			V
Zero-Gate Voltage Drain Current	I _{DSS}	V _{DS} =40V, V _{GS} = 0V			1	μΑ
Gate to Source Leakage Current	Igss	$V_{GS} = \pm 20V$, $V_{DS} = 0V$			±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _{DS} =250µA	1	1.9	2.5	V
Static Drain to Source On-State	Б	I _D = 20A, V _{GS} = 10V	1	3.2	3.8	mΩ
Resistance	R _{DS(on)}	I _D = 10A, V _{GS} = 4.5V	-	4.3	5.4	mΩ
Input Capacitance	Ciss	V _{GS} =0V,		4645		pF
Output Capacitance	Coss	V _{DS} =20V,		436		pF
Reverse Transfer Capacitance	C _{rss}	Frequency=1.0MHz		360		pF
Turn-ON Delay Time	t _{d(on)}			12		ns
Rise Time	tr	$V_{DD} = 20V, I_{D} = 20A$		54		ns
Turn-OFF Delay Time	$t_{\text{d(off)}}$	$V_{GS} = 10V$, $R_G = 3\Omega$		120		ns
Fall Time	t _f			80		ns
	Qg	V _{DS} = 20V,		102		nC
Total Gate Charge	Qgs	V _{GS} = 10V,		15.8		nC
	Q_{gd}	I _D = 20A		22		nC
Diode Forward Voltage	V _{FSD}	I _S = 20A, V _{GS} = 0			1.2	V

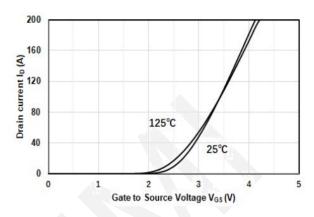
Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



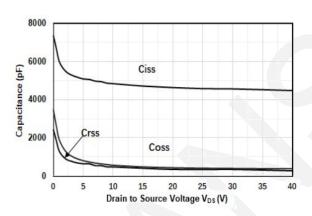
7. Typical electrical and thermal characteristics



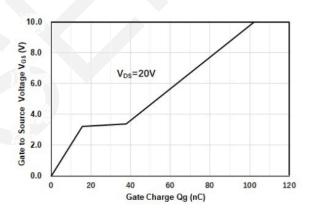
Output Characteristics



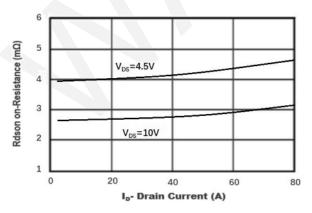
Transfer Characteristics



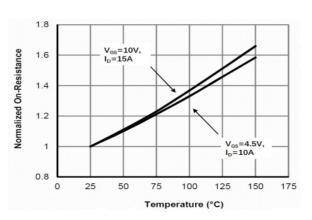
Capacitance Characteristics



Gate Charge

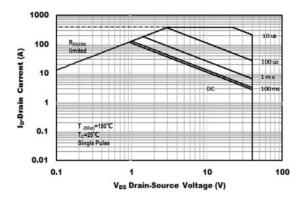


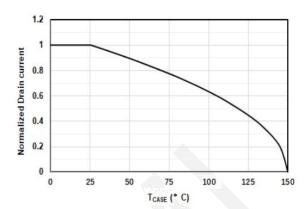
Drain-Source on Resistance



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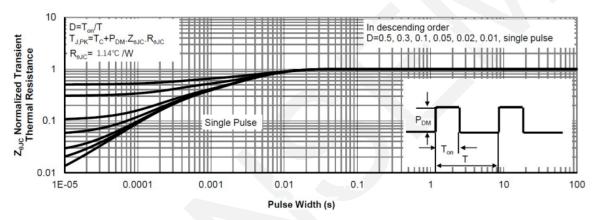






Safe Operation Area

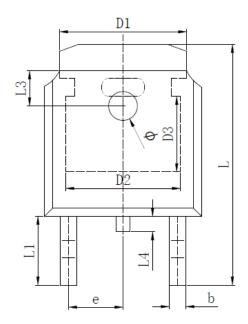
Drain current vs. Case Temperature

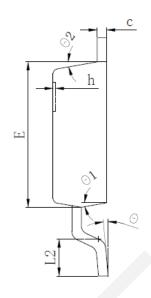


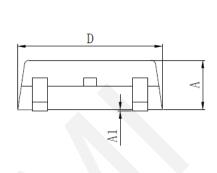
Normalized Maximum Transient Thermal Impedance



8.Package Dimensions







SYMBOL	MILLIMETER			
SIMDOL	MIN	Тур.	MAX	
A	2. 200	2. 300	2. 400	
A1	0.000		0. 127	
b	0.640	0.690	0. 740	
c(电镀后)	0. 460	0. 520	0. 580	
D	6. 500	6. 600	6. 700	
D1		5.334 REF		
D2		4.826 REF		
D3		3.166 REF		
E	6. 000	6. 100	6. 200	
e	2.286 TYP			
h	0.000	0. 100	0. 200	
L	9. 900	10. 100	10. 300	
L1	2.888 REF			
L2	1. 400	1. 550	1. 700	
L3	1.600 REF			
L4	0.600	0.800	1.000	
ф	1. 100	1. 200	1. 300	
θ	0°		8°	
θ1	9° ТҮР			
θ2	9° TYP			



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